# DATA SHEET



# MOS FIELD EFFECT TRANSISTOR NP83P06PDG

# SWITCHING P-CHANNEL POWER MOSFET

## DESCRIPTION

The NP83P06PDG is P-channel MOS Field Effect Transistor designed for high current switching applications.

#### <R> ORDERING INFORMATION

| PART NUMBER           | LEAD PLATING  | PACKING         | PACKAGE          |  |
|-----------------------|---------------|-----------------|------------------|--|
| NP83P06PDG-E1-AY Note | Pure Sn (Tin) | T               |                  |  |
| NP83P06PDG-E2-AY Note |               | Tape 800 p/reel | TO-263 (MP-25ZP) |  |

Note Pb-free (This product does not contain Pb in external electrode.)

#### FEATURES

• Super low on-state resistance

 $R_{DS(on)1}$  = 8.8 m $\Omega$  MAX. (V<sub>GS</sub> = -10 V, I<sub>D</sub> = -41.5 A)

 $R_{DS(on)2} = 12 \text{ m}\Omega \text{ MAX.} (V_{GS} = -4.5 \text{ V}, \text{ ID} = -41.5 \text{ A})$ 

• High current rating: ID(DC) = ∓83 A

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (VGs = 0 V)             | VDSS        | -60         | V  |
|---|-------------|-------------|----|
| Gate to Source Voltage (VDs = 0 V)              | Vgss        | ∓20         | V  |
| Drain Current (DC) (Tc = 25°C)                  | D(DC)       | ∓83         | А  |
| Drain Current (pulse) <sup>Note1</sup>          | D(pulse)    | ∓249        | А  |
| Total Power Dissipation (Tc = $25^{\circ}$ C)   | <b>P</b> T1 | 150         | W  |
| Total Power Dissipation (T <sub>A</sub> = 25°C) | Pt2         | 1.8         | W  |
| Channel Temperature                             | Tch         | 175         | °C |
| Storage Temperature                             | Tstg        | -55 to +175 | °C |
| Single Avalanche Current Note2                  | las         | 49          | А  |
| Single Avalanche Energy Note2                   | Eas         | 240         | mJ |

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

**2.** Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = -30 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> =  $-20 \rightarrow 0$  V

#### THERMAL RESISTANCE

| Channel to Case Thermal Resistance    | Rth(ch-C) | 1.0  | °C/W |
|---------------------------------------|-----------|------|------|
| Channel to Ambient Thermal Resistance | Rth(ch-A) | 83.3 | °C/W |

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(TO-263)

The mark <R> shows major revised points.

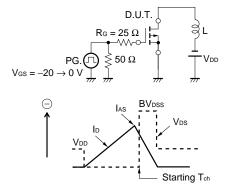
The revised points can be easily searched by copying an "<R>" in the PDF file and specifying it in the "Find what:" field.

| CHARACTERISTICS                          | SYMBOL              | TEST CONDITIONS                                    | MIN. | TYP.  | MAX. | UNIT |
|--|---------------------|--|------|-------|------|------|
| Zero Gate Voltage Drain Current          | loss                | V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V     |      |       | -10  | μA   |
| Gate Leakage Current                     | Igss                | V <sub>GS</sub> = ∓20 V, V <sub>DS</sub> = 0 V     |      |       | ∓100 | nA   |
| Gate to Source Threshold Voltage         | V <sub>GS(th)</sub> | V <sub>DS</sub> = −10 V, I <sub>D</sub> = −1 mA    | -1.0 | -1.6  | -2.5 | V    |
| Forward Transfer Admittance Note         | y <sub>fs</sub>     | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -41.5 A  | 30   | 60    |      | S    |
| Drain to Source On-state Resistance Note | RDS(on)1            | Vgs = -10 V, Id = -41.5 A                          |      | 6.9   | 8.8  | mΩ   |
|  | RDS(on)2            | V <sub>GS</sub> = −4.5 V, I <sub>D</sub> = −41.5 A |      | 8.0   | 12   | mΩ   |
| Input Capacitance                        | Ciss                | V <sub>DS</sub> = -10 V,                           |      | 10100 |      | pF   |
| Output Capacitance                       | Coss                | V <sub>GS</sub> = 0 V,                             |      | 1140  |      | pF   |
| Reverse Transfer Capacitance             | Crss                | f = 1 MHz  |      | 660   |      | pF   |
| Turn-on Delay Time                       | td(on)              | V <sub>DD</sub> = -30 V, I <sub>D</sub> = -41.5 A, |      | 36    |      | ns   |
| Rise Time                                | tr                  | V <sub>GS</sub> = -10 V,                           |      | 20    |      | ns   |
| Turn-off Delay Time                      | td(off)             | R <sub>G</sub> = 0 Ω                               |      | 230   |      | ns   |
| Fall Time                                | tr                  |  |      | 200   |      | ns   |
| Total Gate Charge                        | Q <sub>G</sub>      | Vdd = -48 V,                                       |      | 190   |      | nC   |
| Gate to Source Charge                    | Q <sub>GS</sub>     | V <sub>GS</sub> = -10 V,                           |      | 20    |      | nC   |
| Gate to Drain Charge                     | Qgd                 | ID = -83 A   |      | 53    |      | nC   |
| Body Diode Forward Voltage Note          | V <sub>F(S-D)</sub> | IF = -83 A, VGS = 0 V                              |      | 0.94  | 1.5  | V    |
| Reverse Recovery Time                    | trr                 | IF = -83 A, VGS = 0 V,                             |      | 63    |      | ns   |
| Reverse Recovery Charge                  | Qrr                 | di/dt = −100 A/ <i>µ</i> s                         |      | 101   |      | nC   |

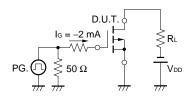
**Note** Pulsed test PW  $\leq$  350  $\mu$ s, Duty Cycle  $\leq$  2%

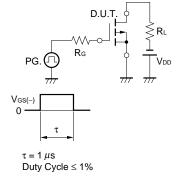
#### TEST CIRCUIT 1 AVALANCHE CAPABILITY

#### **TEST CIRCUIT 2 SWITCHING TIME**



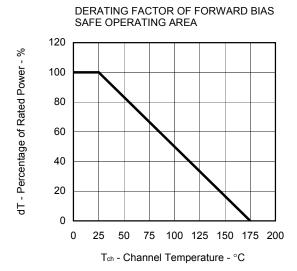
## TEST CIRCUIT 3 GATE CHARGE



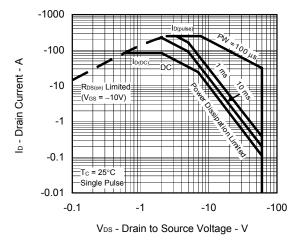


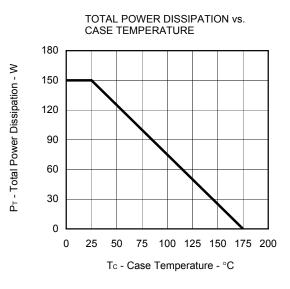
| Vgs                          | V <sub>GS(-)</sub>  |   |
|------------------------------|---|---|
| Wave Form                    | 0   | • |
| V <sub>DS</sub><br>Wave Form | VDS(-)<br>VDS<br>0<br>td(on)<br>ton<br>tor<br>tor<br>tor<br>tor | • |

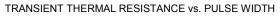
# TYPICAL CHARACTERISTICS (TA = 25°C)

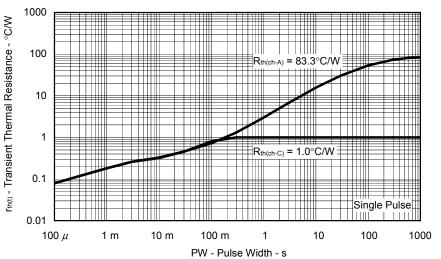




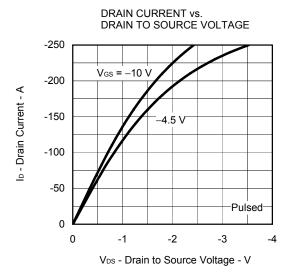




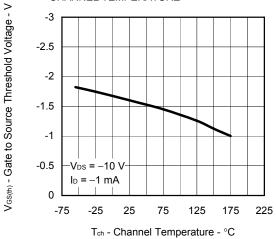




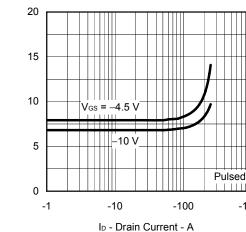
Data Sheet D18691EJ3V0DS



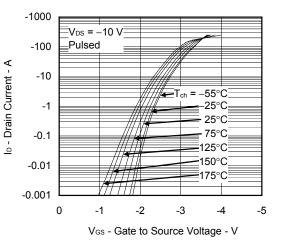




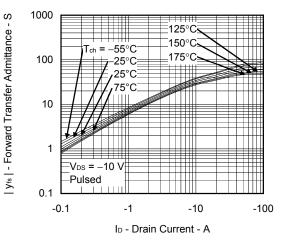
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



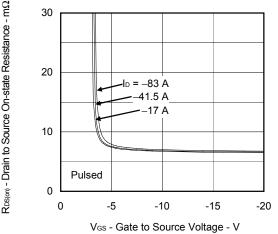




FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

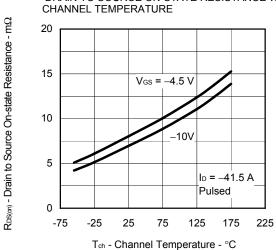


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



-1000

 $R_{DS(on)}$  - Drain to Source On-state Resistance -  $m\Omega$ 



SWITCHING CHARACTERISTICS

-10

td(of

tr

-1

ID - Drain Current - A

 $V_{DD} = -30 V$ 

Vgs = -10 V

 $R_G = 0 \Omega$ 

1000

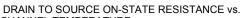
100

10

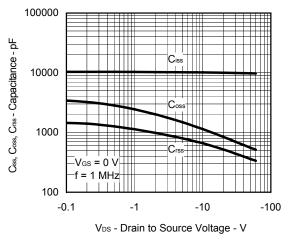
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-0.1

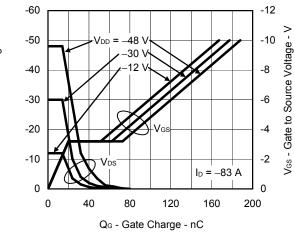
ta(on), tr, ta(off), tr - Switching Time - ns



CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

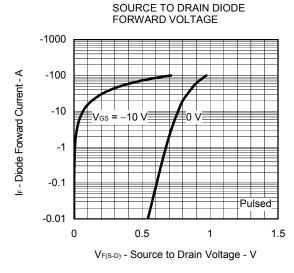


DYNAMIC INPUT/OUTPUT CHARACTERISTICS

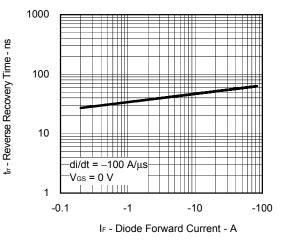


V<sub>DS</sub> - Drain to Source Voltage - V

-100

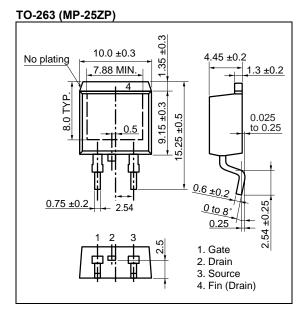


REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT

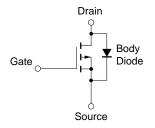


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## PACKAGE DRAWING (Unit: mm)



#### EQUIVALENT CIRCUIT



**Remark** Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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